Dual TrenchPLUS logic level FET Rev. 01 — 14 May 2009

Product data sheet

Integrated temperature sensors

Power distribution

Solenoid drivers

Product profile 1.

1.1 General description

Dual N-channel enhancement mode field-effect power transistor in SO20. Device is manufactured using NXP High-Performance (HPA) TrenchPLUS technology, featuring very low on-state resistance, integrated current sensing transistors and over temperature protection diodes.

1.2 Features and benefits

- Integrated current sensors
- 1.3 Applications
 - Lamp switching
 - Motor drive systems

1.4 Quick reference data

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics, FET1 a	nd FET2				
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 V; I_D = 5 A;$ $T_j = 25 °C; see Figure 16;$ see Figure 17	-	42.5	50	mΩ
I _D /I _{sense}	ratio of drain current to sense current	T _j = 25 °C; V _{GS} = 5 V; see <u>Figure 18</u>	2430	2700	2970	A/A
V _{(BR)DSS}	drain-source breakdown voltage	$ T_j = 25 \text{ °C}; \text{V}_{\text{GS}} = 0 \text{V}; \\ I_{\text{D}} = 250 \mu\text{A} $	55	-	-	V



2. Pinning information

PinSymbolDescriptionSimplified outlineGraphic symbol1G1gate 12IS1current sense 13D1drain 14A1anode 15C1cathode 16G2gate 27IS2current sense 28D2drain 29A2anode 210C2cathode 211D2drain 212KS2Kelvin source 213S2source 214S2source 116D1drain 117KS1Kelvin source 118S1source 119S1source 120D1drain 1	Table 2.	Pinning	j information		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Pin	Symbol	Description	Simplified outline	Graphic symbol
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	1	G1	gate 1		
3D1drain 14A1anode 15C1cathode 16G2gate 27IS2current sense 28D2drain 29A2anode 210C2cathode 211D2drain 212KS2Kelvin source 213S2source 214S2source 215D2drain 117KS1Kelvin source 118S1source 119S1source 1	2	IS1	current sense 1		D1 A1 D2 A2
4A1anode 1 5 C1cathode 1 6 G2gate 2 7 IS2current sense 2 8 D2drain 2 9 A2anode 2 10 C2cathode 2 11 D2drain 2 12 KS2Kelvin source 2 13 S2source 2 14 S2source 2 15 D2drain 2 16 D1drain 1 17 KS1Kelvin source 1 18 S1source 1 19 S1source 1	3	D1	drain 1		FET1 FET2
5C1cathode 16G2gate 27IS2current sense 28D2drain 29A2anode 210C2cathode 211D2drain 212KS2Kelvin source 213S2source 214S2source 215D2drain 117KS1Kelvin source 118S1source 119S1source 1	4	A1	anode 1	þ	
0 02 gate 2 1 10 7 IS2 current sense 2 SOT163-1 G1 IS1 S1 KS1 C1 G2 IS2 S2 KS2 C2 9 A2 anode 2 (SO20) G1 IS1 S1 KS1 C1 G2 IS2 S2 KS2 C2 003aaa745 003aaa745 003aaa745 003aaa745 11 D2 drain 2 003aaa745 12 KS2 Kelvin source 2 003aaa745 13 S2 source 2 003aaa745 16 D1 drain 1 11 17 KS1 Kelvin source 1 11 18 S1 source 1 11 19 S1 source 1 11	5	C1	cathode 1		
8 D2 drain 2 9 A2 anode 2 10 C2 cathode 2 11 D2 drain 2 12 KS2 Kelvin source 2 13 S2 source 2 14 S2 source 2 15 D2 drain 1 17 KS1 Kelvin source 1 18 S1 source 1 19 S1 source 1	6	G2	gate 2		
8 D2 drain 2 (SO20) G1 IS1 S1 KS1 C1 G2 IS2 S2 KS2 C2 9 A2 anode 2	7	IS2	current sense 2	SOT163-1	
9A2anode 210C2cathode 211D2drain 212KS2Kelvin source 213S2source 214S2source 215D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	8	D2	drain 2	(SO20)	
11D2drain 212KS2Kelvin source 213S2source 214S2source 215D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	9	A2	anode 2		000444745
12KS2Kelvin source 213S2source 214S2source 215D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	10	C2	cathode 2		
13S2source 214S2source 215D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	11	D2	drain 2		
14S2source 215D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	12	KS2	Kelvin source 2		
15D2drain 216D1drain 117KS1Kelvin source 118S1source 119S1source 1	13	S2	source 2		
16D1drain 117KS1Kelvin source 118S1source 119S1source 1	14	S2	source 2		
17KS1Kelvin source 118S1source 119S1source 1	15	D2	drain 2		
18S1source 119S1source 1	16	D1	drain 1		
19 S1 source 1	17	KS1	Kelvin source 1		
	18	S1	source 1		
20 D1 drain 1	19	S1	source 1		
	20	D1	drain 1		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK9MLL-55PLL	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
Limiting val	ues, FET1 and FET2					
V _{DS}	drain-source voltage	25 °C < T _j < 150 °C		-	55	V
V _{DGR}	drain-gate voltage	R_{GS} = 20 kΩ; 25 °C < T _j < 150 °C		-	55	V
V _{GS}	gate-source voltage			-15	15	V
I _D	drain current	$T_{sp} = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } Figure 2; \text{ see } Figure 3;$	[1][2]	-	5.9	А
		$T_{sp} = 100 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } \frac{\text{Figure 2}}{2};$	[1][2]	-	3.7	А
I _{DM}	peak drain current	$T_{sp} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed}; \text{ see } \frac{\text{Figure 3}}{10 \mu\text{s}}$		-	61.3	А
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 1</u>		-	3.3	W
T _{stg}	storage temperature			-55	150	°C
Tj	junction temperature			-55	150	°C
Visol(FET-TSD)	FET to temperature sense diode isolation voltage			-	100	V
Source-drai	n diode, FET1 and FET2	2				
I _S	source current	T _{sp} = 25 °C;	[1][2]	-	4.7	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{sp} = 25 \ ^{\circ}C$		-	61.3	А
Avalanche r	uggedness, FET1 and F	ET2				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$I_D = 5.9 \text{ A}; \text{ V}_{sup} \leq 55 \text{ V}; \text{ V}_{GS} = 5 \text{ V}; \text{ T}_{j(init)} = 25 \text{ °C};$ unclamped; see <u>Figure 4</u> ;	[3][4] [5]	-	72	mJ
Electrostatio	c discharge, FET1 and F	ET2				
V _{ESD}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 k\Omega; pins 3, 16 and 20 to pins 1, 2, 17, 18 and 19 shorted		-	4	kV
		HBM; C = 100 pF; R = 1.5 k Ω ; pins 8, 11 and 15 to pins 6, 7, 12, 13 and 14 shorted		-	4	kV
		HBM; C = 100 pF; R = 1.5 k Ω ; all pins		-	0.15	kV

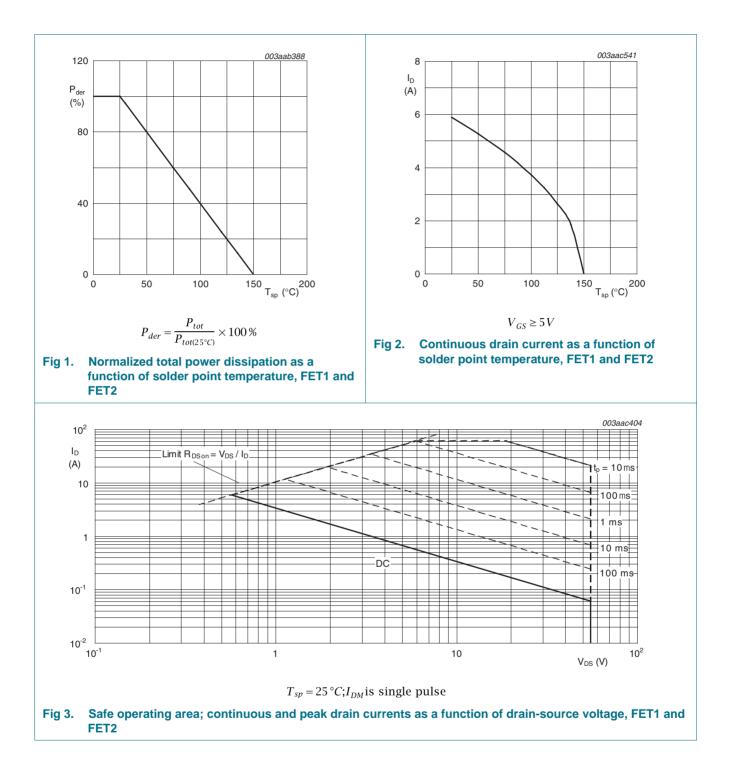
[1] Single device conducting.

[2] Current is limited by chip power dissipation rating.

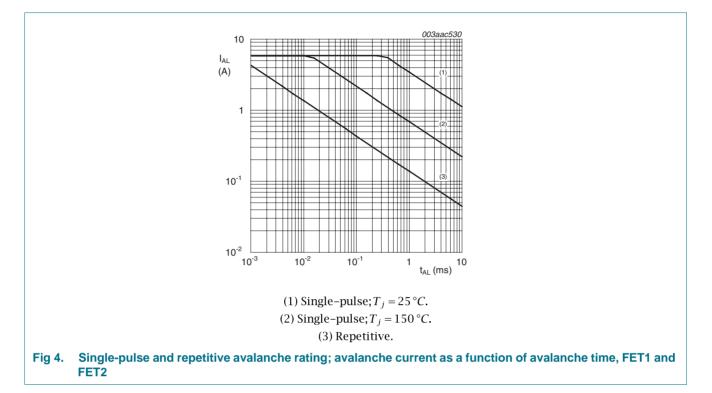
[3] Single-pulse avalanche rating limited by maximum junction temperature of 150 °C.

[4] Repetitive rating defined in avalanche rating figure.

[5] Refer to application note AN10273 for further information.



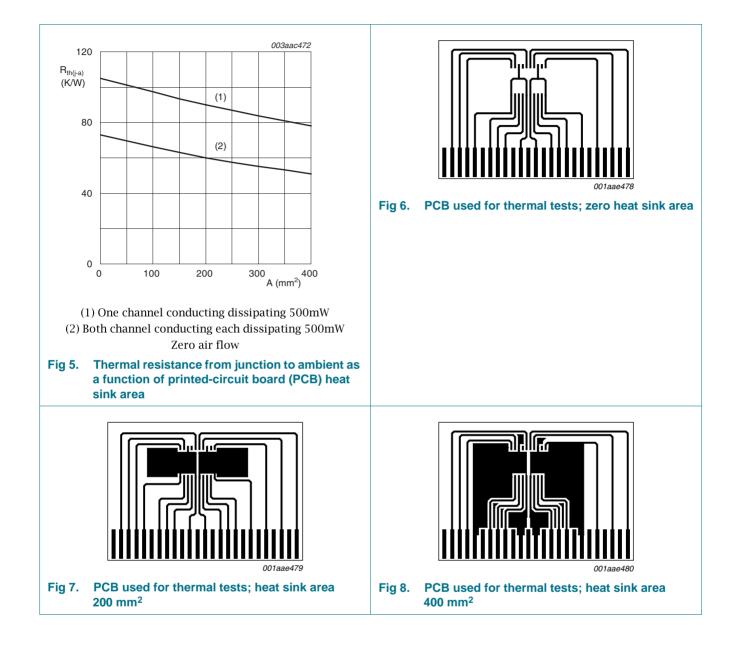
Dual TrenchPLUS logic level FET



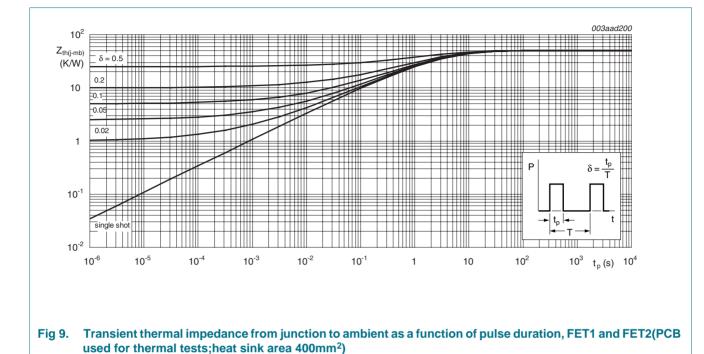
5. Thermal characteristics

Table 5.	Thermal characteristics										
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit					
R _{th(j-sp)}	thermal resistance from	FET1	-	27	37	K/W					
	junction to solder point	FET2	-	27	37	K/W					
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on printed-circuit board; Both channel conducting; zero heat sink area; see <u>Figure 5</u> ; see <u>Figure 6</u>	-	73	-	K/W					
		mounted on printed-circuit board; Both channel conducting; 200 mm ² copper heat sink area; see <u>Figure 5</u> ; see <u>Figure 7</u>	-	60	-	K/W K/W K/W					
		mounted on printed-circuit board; Both channel conducting; 400 mm ² copper heat sink area; see <u>Figure 5</u> ; see <u>Figure 8</u>	-	51	-	K/W					
		mounted on printed-circuit board; One channel conducting; zero heat sink area; see <u>Figure 5</u> ; see <u>Figure 6</u>	-	105	-	K/W					
		mounted on printed-circuit board; One channel conducting; 200 mm ² copper heat sink area; see <u>Figure 5</u> ; see <u>Figure 7</u>	-	90	-	K/W					
		mounted on printed-circuit board; One channel conducting; 400 mm ² copper heat sink area; see Figure 5; see Figure 8	-	78	-	K/W					

Table 5. Thermal characteristics



Dual TrenchPLUS logic level FET



6. Characteristics

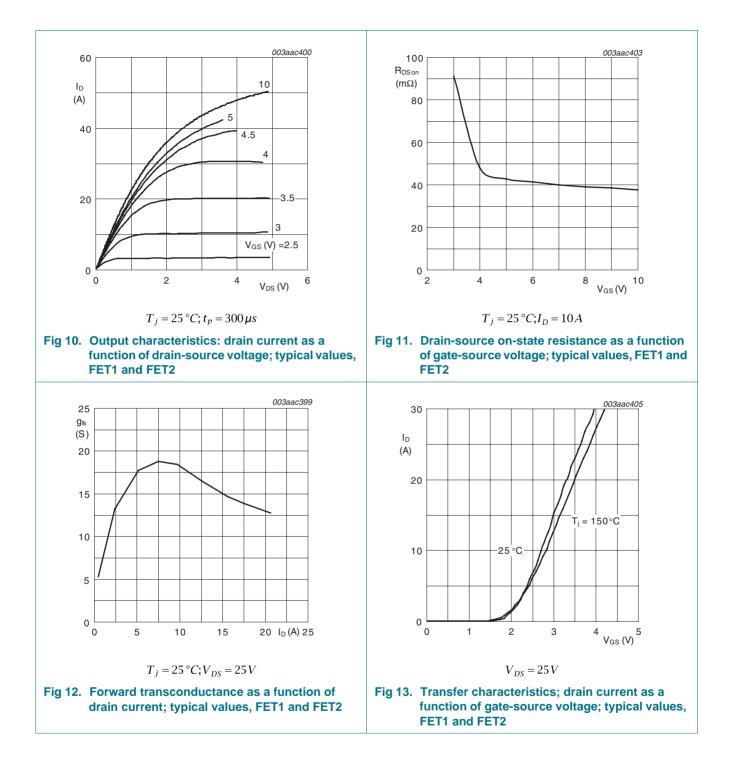
Table 6.Characteristics

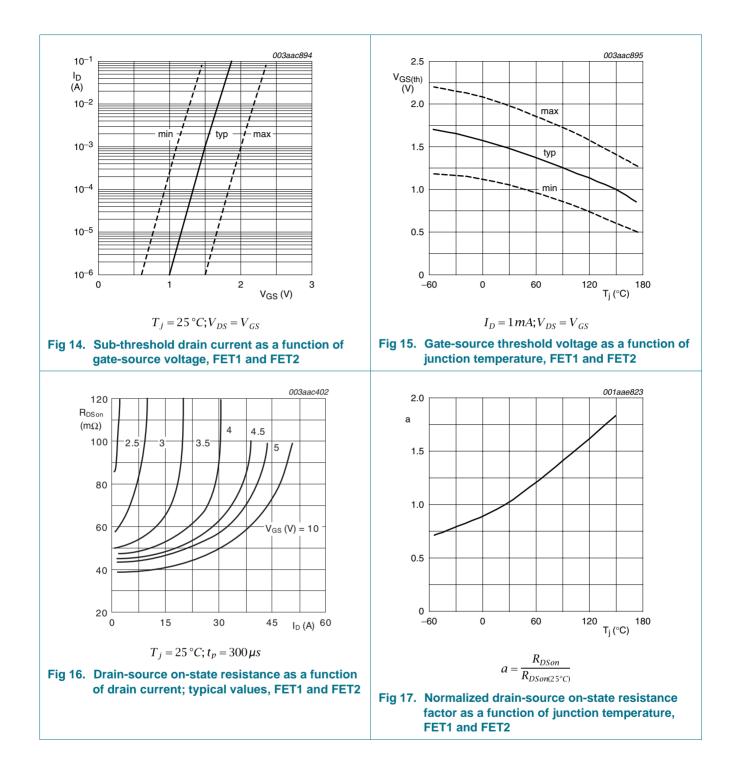
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics, FET1 and F	ET2				
V _{(BR)DSS}	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	55	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}; \text{ see}$ Figure 14; see Figure 15	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C}; \text{ see}$ Figure 14; see Figure 15	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; \text{ see}$ Figure 14; see Figure 15	-	-	2.3	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.02	3	μΑ
		V_{DS} = 40 V; V_{GS} = 0 V; T_j = 150 °C	-	-	125	μΑ
I _{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 15 \text{ V}; T_j = 25 \text{ °C}$	-	2	300	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure}}{16}; \text{ see } \frac{\text{Figure } 17}{17}$	-	42.5	50	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}; T_j = 150 \text{ °C}; \text{ see}$ Figure 16; see Figure 17	-	-	97	mΩ
		V _{GS} = 4.5 V; I _D = 5 A; T _j = 25 °C; see <u>Figure 16</u> ; see <u>Figure 17</u>	-	47.5	55.8	mΩ
		V_{GS} = 10 V; I_D = 5 A; T_j = 25 °C; see Figure 16; see Figure 17	-	41	45.3	V V V V μΑ μΑ nA mΩ
I _D /I _{sense}	ratio of drain current to sense current	$T_j = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } Figure 18$	2430	2700	2970	A/A

Dual TrenchPLUS logic level FET

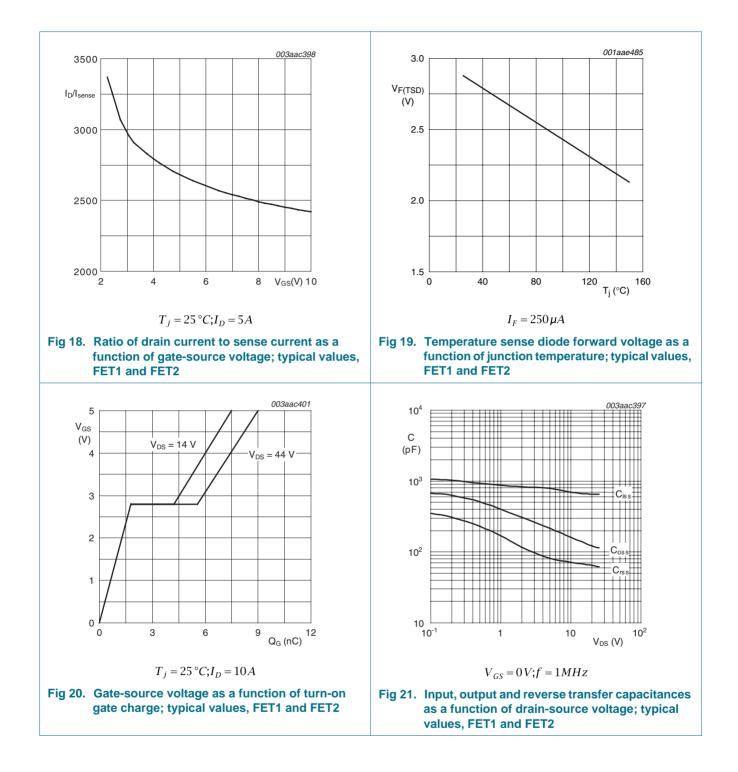
Table 6.	Characteristics contin	ued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
S _{F(TSD)}	temperature sense diode temperature coefficient	I _F = 250 μA; 25 °C < T _j < 150 °C; see <u>Figure 19</u>	-5.4	-5.7	-6	mV/K
V _{F(TSD)}	temperature sense diode forward voltage	$I_F = 250 \ \mu\text{A}; T_j = 25 \ ^\circ\text{C}; \text{see} \frac{\text{Figure 19}}{100}$	2.855	2.9	2.945	V
Dynamic	characteristics, FET1 an	d FET2				
Q _{G(tot)}	total gate charge	$I_D = 5 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V}; \text{ see}$	-	8.3	-	nC
Q _{GS}	gate-source charge	Figure 20	-	3.14	-	nC
Q _{GD}	gate-drain charge		-	3.67	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	670	893	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 21}{\text{Figure } 21}$	-	112	134	pF
C _{rss}	reverse transfer capacitance		-	60	82	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 3 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	16	-	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega$	-	26	-	ns
t _{d(off)}	turn-off delay time		-	42	-	ns
t _f	fall time		-	22	-	ns
L _D	internal drain inductance	From pin to centre of die	-	0.85	-	nH
L _S	internal source inductance	From source lead to source bonding pad	-	1.9	-	nH
Source-d	rain diode, FET1 and FE	T2				
V _{SD}	source-drain voltage	$I_S = 5 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure}}{22}$	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 5 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = -10 \text{ V};$	-	40.6	-	ns
Q _r	recovered charge	$V_{DS} = 30 V$	-	57	-	nC

Table 6. Characteristics ... continued

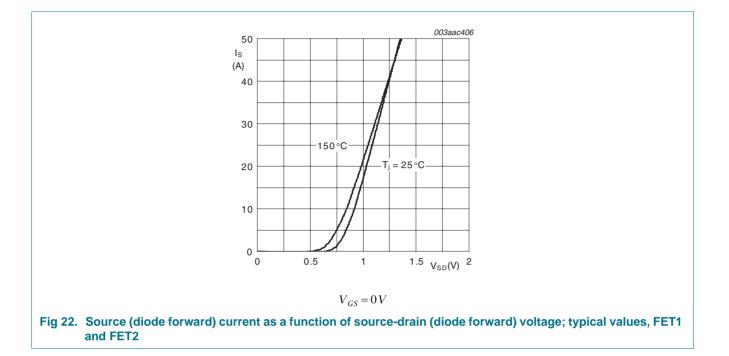




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BUK9MLL-55PLL_1



7. Package outline

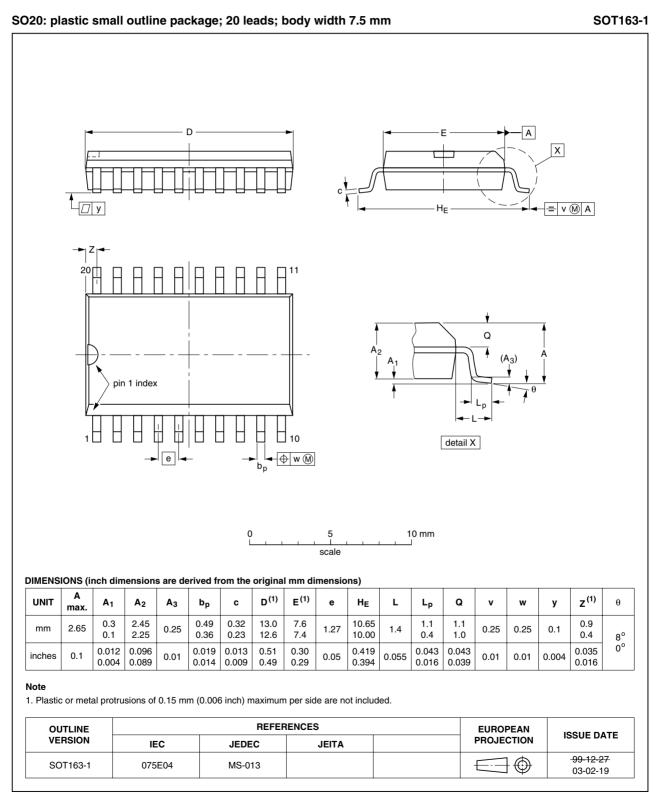


Fig 23. Package outline SOT163-1

BUK9MLL-55PLL_1

8. Revision history

Table 7. Revision his	Table 7. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
BUK9MLL-55PLL_1	20090514	Product data sheet	-	-		

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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